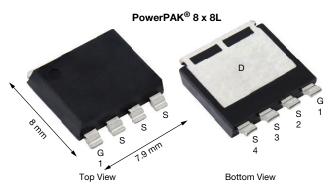


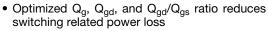
N-Channel 60 V (D-S) 175 °C MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00092			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.00115			
Q _g typ. (nC)	141			
I _D (A) ^a	373			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV power MOSFET
- Fully lead (Pb)-free device

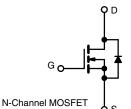




- 50 % smaller footprint than D2PAK (TO-263)
- 100 % R_a and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Synchronous rectification
- OR-ing
- Motor drive control
- Battery management
- Power supply



ORDERING INFORMATION	
Package	PowerPAK 8 x 8L
Lead (Pb)-free and halogen-free	SIJH600E-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	60	V	
Gate-source voltage		V _{GS}	± 20		
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		373		
	T _C = 70 °C	1 , [312		
	T _A = 25 °C	I _D	37 b		
	T _A = 70 °C	1 [31 ^b	^	
Pulsed drain current (t = 100 μs)		I _{DM}	500	A	
Continuous source-drain diode current	T _C = 25 °C	,	303		
	T _A = 25 °C	I _S	3 p		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	80		
Single pulse avalanche energy	L = U. I IIII	E _{AS}	320	mJ	
Maximum power dissipation	T _C = 25 °C		333		
	T _C = 70 °C	1 , [233	w	
	T _A = 25 °C	P _D	3.3 ^b	VV	
	T _A =70 °C	Ţ [2.3 ^b		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	Steady state	R _{thJA}	36	45	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	0.36	0.45	C/VV	

Notes

T_C = 25 °C Surface mounted on 1" x 1" FR4 board

c. See solder profile (www.vishay.com/doc?73257). The PowerPAK 8 x 8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
 d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components



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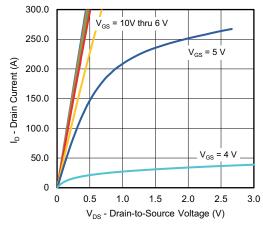
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	30	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-8.3	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20$	-	-	100	nA	
Zero gate voltage drain current		V _{DS} = 60 V, V _{GS} = 0 V	-	-	1		
	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA	
	5	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.00065	0.00092		
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$	-	0.00080	0.00115	Ω	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 50 \text{ A}$	-	170	-	S	
Dynamic ^b					•		
Input capacitance	C _{iss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz	-	9950	-	pF	
Output capacitance	C _{oss}		-	2575	-		
Reverse transfer capacitance	C_{rss}		-	78	-		
Tatal sate aboves	0	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ $V_{DS} = 30 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$	-	141	212		
Total gate charge	Q_g		-	107	161		
Gate-source charge	Q _{gs}		-	42	-	nC	
Gate-drain charge	Q _{gd}		-	20	-		
Gate resistance	R_{g}	f = 1 MHz	0.23	1.2	2.4	Ω	
Turn-on delay time	t _{d(on)}		-	22	45		
Rise time	t _r	$\begin{split} V_{DD} = 30 \text{ V, } R_L = 10 \Omega, \ I_D \cong 3 \text{ A,} \\ V_{GEN} = 10 \text{ V, } R_g = 1 \Omega \end{split}$	-	15	30		
Turn-off delay time	t _{d(off)}		-	55	110		
Fall time	t _f		-	20	40		
Turn-on delay time	t _{d(on)}		-	30	60	ns	
Rise time	t _r	$\begin{split} V_{DD} = 30 \text{ V, } R_L = 10 \Omega, I_D & \equiv 3 \text{ A,} \\ V_{GEN} = 7.5 \text{ V, } R_g = 1 \Omega \end{split}$	-	20	40		
Turn-off delay time	t _{d(off)}		-	50	100		
Fall time	t _f		-	20	40		
Drain-Source Body Diode Characterist	cs				•		
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	303		
Pulse diode forward current	I _{SM}		-	-	500	Α	
Body diode voltage	V_{SD}	I _S = 10 A, V _{GS} = 0 V	-	0.73	1.1	V	
Body diode reverse recovery time	t _{rr}		-	87	175	ns	
Body diode reverse recovery charge	Q _{rr}		-	130	260	nC	
Reverse recovery fall time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	42	-		
Reverse recovery rise time	t _b		-	45	-	ns	

Notes

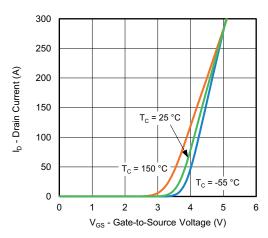
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

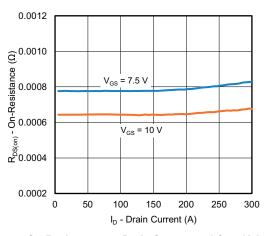




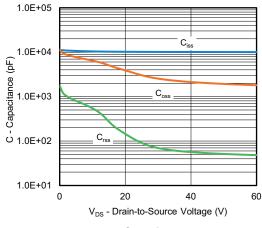
Output Characteristics



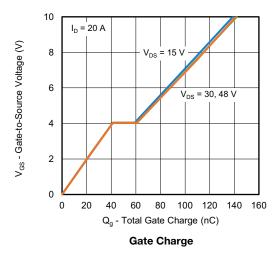
Transfer Characteristics

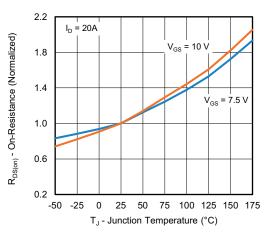


On-Resistance vs. Drain Current and Gate Voltage



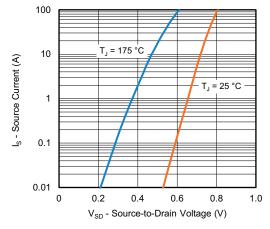
Capacitance



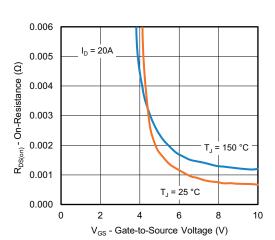


On-Resistance vs. Junction Temperature

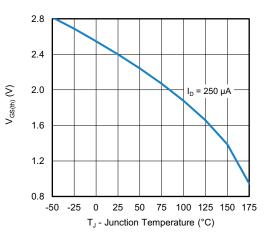




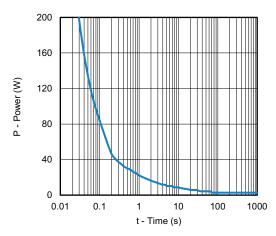
Source-Drain Diode Forward Voltage



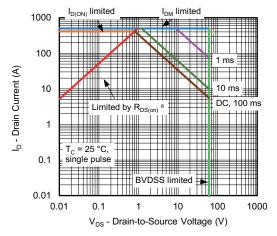
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

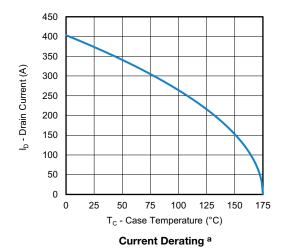


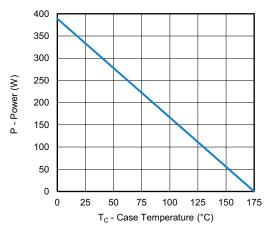
Safe Operating Area, Junction-to-Ambient

Note

a. $V_{GS} > minimum V_{GS}$ at which $R_{DS(on)}$ is specified





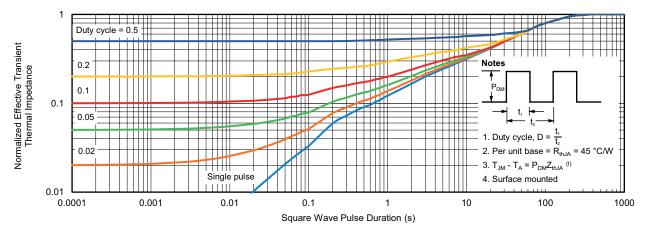


Power, Junction-to-Case

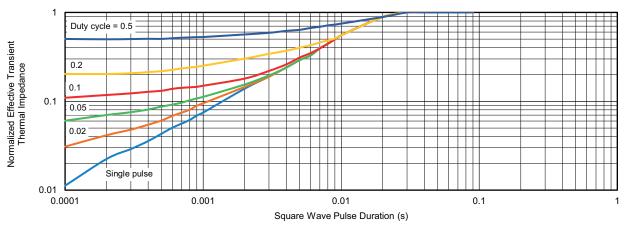
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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